

ND2012 SERIES

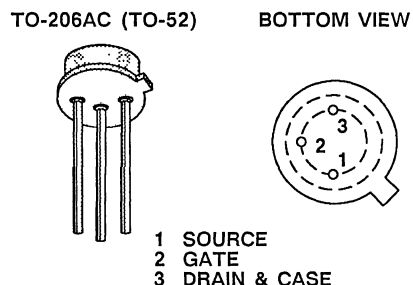
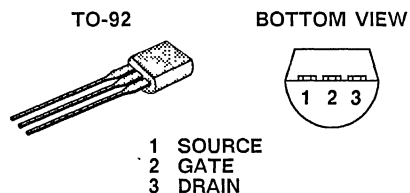


N-Channel Depletion-Mode MOS Transistors

PRODUCT SUMMARY

PART NUMBER	$V_{(BR)DSV}$ (V)	$r_{DS(ON)}$ (Ω)	I_D (A)	PACKAGE
ND2012L	200	12	0.16	TO-92
ND2012E	200	12	0.22	TO-206AC

Performance Curves: VDDQ20 (See Section 7)



ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ unless otherwise noted)

PARAMETERS/TEST CONDITIONS		SYMBOL	ND2012L	ND2012E ²	UNITS
Drain-Source Voltage		V_{DS}	200	200	V
Gate-Source Voltage		V_{GS}	± 30	± 20	
Continuous Drain Current	$T_A = 25^\circ\text{C}$	I_D	0.16	0.22	A
	$T_A = 100^\circ\text{C}$		0.10	0.14	
Pulsed Drain Current ¹		I_{DM}	0.8	0.8	
Power Dissipation	$T_A = 25^\circ\text{C}$	P_D	0.80	1.5	W
	$T_A = 100^\circ\text{C}$		0.32	0.60	
Operating Junction and Storage Temperature		T_J, T_{stg}	-55 to 150		$^\circ\text{C}$
Lead Temperature (1/16" from case for 10 seconds)		T_L	300		

THERMAL RESISTANCE

THERMAL RESISTANCE	SYMBOL	ND2012L	ND2012E	UNITS
Junction-to-Ambient	R_{thJA}	156	400	$^\circ\text{C}/\text{W}$

¹Pulse width limited by maximum junction temperature

²Reference case for all temperature testing

ELECTRICAL CHARACTERISTICS ¹				LIMITS		
PARAMETER	SYMBOL	TEST CONDITIONS	TYP ²	ND2012		UNIT
				MIN	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(BR)DSV}$	$V_{GS} = -8\text{ V}, I_D = 10\ \mu\text{A}$	220	200		V
Gate-Source Cutoff Voltage	$V_{GS(OFF)}$	$V_{DS} = 5\text{ V}, I_D = 10\ \mu\text{A}$	-3	-1.5	-4	
Gate-Body Leakage	I_{GSS}	$V_{DS} = 0\text{ V}$ $V_{GS} = \pm 20\text{ V}$ $T_J = 125^\circ\text{C}$	± 0.1 ± 5		± 10 ± 50	nA
Drain Cutoff Current	$I_{D(OFF)}$	$V_{DS} = 160\text{ V}$ $V_{GS} = -8\text{ V}$ $T_J = 125^\circ\text{C}$	0.2 5		1 200	μA
Drain Saturation Current ³	I_{DSS}	$V_{DS} = 10\text{ V}, V_{GS} = 0\text{ V}$	400	30		mA
Drain-Source On-Resistance ³	$r_{DS(ON)}$	$V_{GS} = 2\text{ V}, I_D = 20\text{ mA}$	7			Ω
		$V_{GS} = 0\text{ V}$ $I_D = 20\text{ mA}$ $T_J = 125^\circ\text{C}$	8 15		12 30	
Forward Transconductance	g_{FS}	$V_{DS} = 7.5\text{ V}, I_D = 20\text{ mA}$	55			mS
Common Source Output Conductance ³	g_{OS}		75			μS
DYNAMIC						
Input Capacitance	C_{ISS}	$V_{DS} = 25\text{ V}$ $V_{GS} = -5\text{ V}$ $f = 1\text{ MHz}$	35		100	pF
Output Capacitance	C_{OSS}		10		20	
Reverse Transfer Capacitance	C_{RSS}		2		5	
SWITCHING						
Turn-On Time	$t_{d(ON)}$	$V_{DD} = 25\text{ V}, R_L = 1250\ \Omega$ $I_D = 20\text{ mA}, V_{GEN} = -5\text{ V}$ $R_G = 25\ \Omega$ (Switching time is essentially independent of operating temperature)	20			ns
	t_r		20			
Turn-Off Time	$t_{d(OFF)}$		10			
	t_f		10			

- NOTES: 1. $T_A = 25^\circ\text{C}$ unless otherwise noted, $T_C = 25^\circ\text{C}$ for ND2012E.
 2. For design aid only, not subject to production testing.
 3. Pulse test; $PW = 300\ \mu\text{s}$, duty cycle $\leq 2\%$.